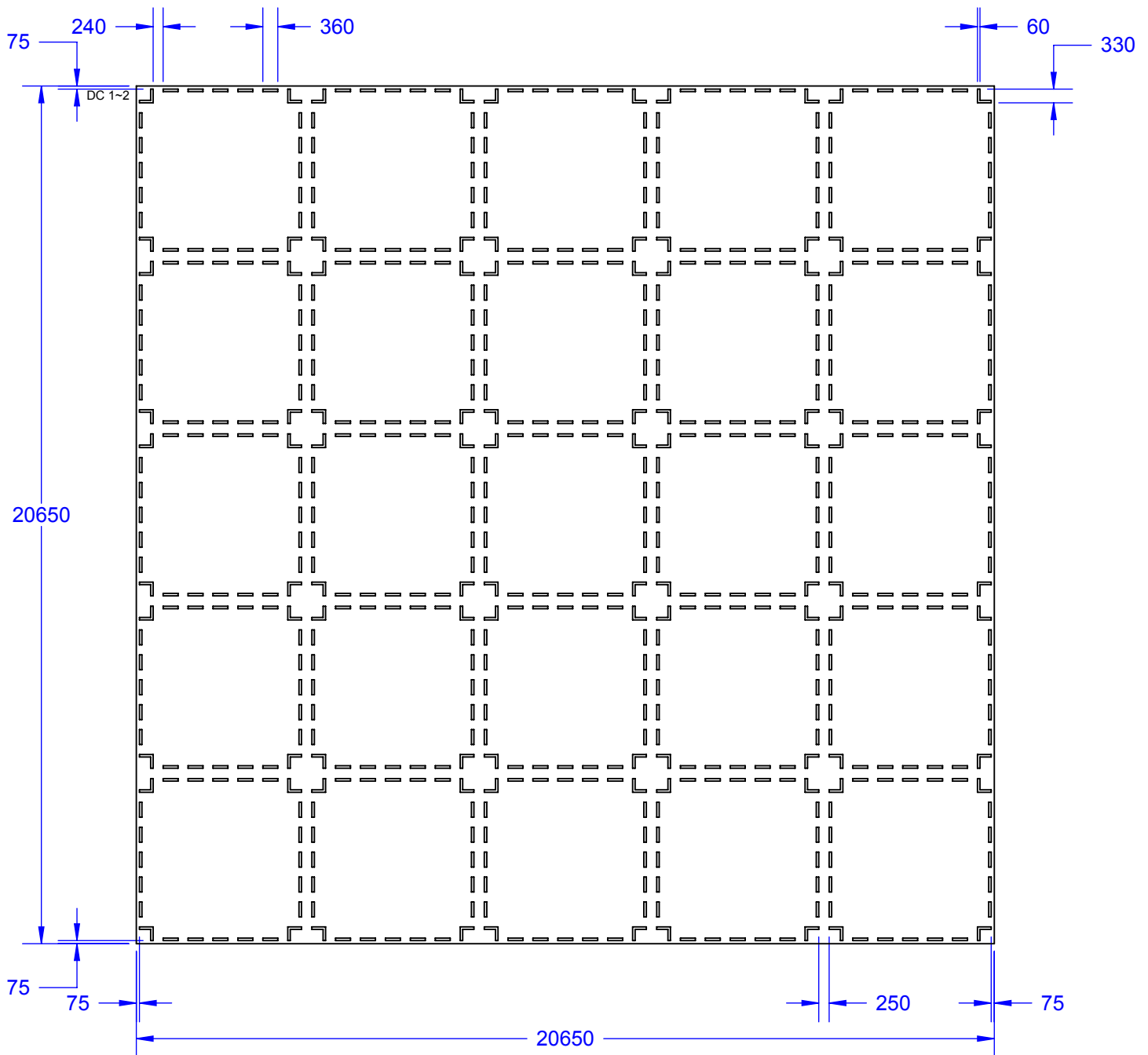


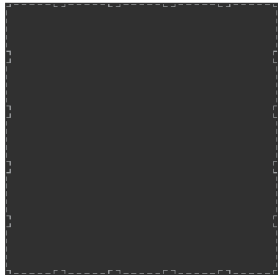
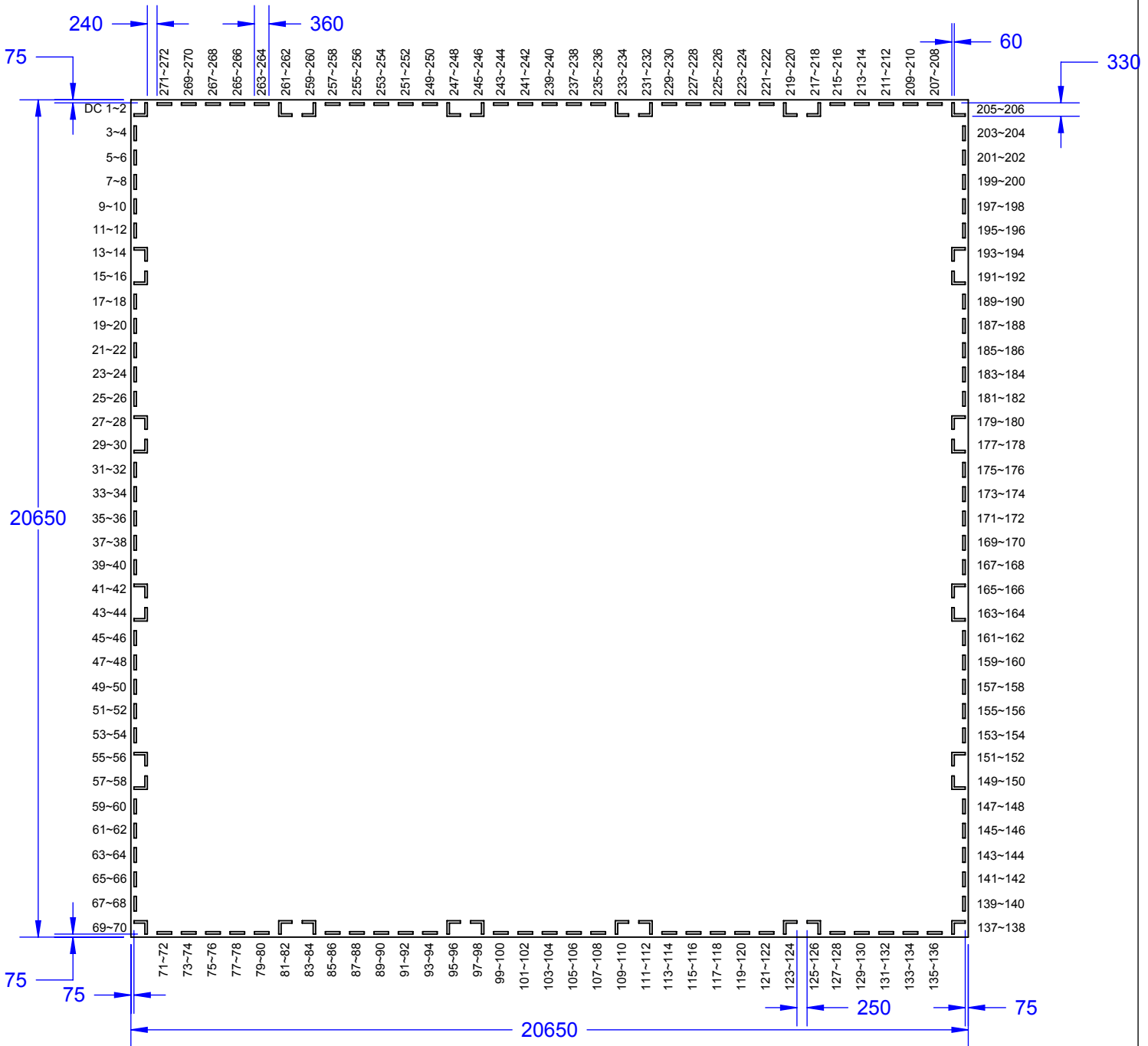
DAISY CHAIN TEST DIE WIRE BONDABLE SHOWN WITH CENTER PADS



- Notes: (Unless Otherwise Specified)
1. DIE MATERIAL IS SILICON.
 2. DIE THICKNESS 250 μ m ~ 725 μ m.
 3. METALLIZATION 1.0 μ m ALUMINUM (Al).
 4. DIE IS WITHOUT PASSIVATION.
 5. WIRE BONDABLE WITH GOLD (Au) WIRE.
 6. DAISY CHAIN PAIRS.

| | | | | | |
|-------------|----------|---|-----------|-------------|--------------|
| APPROVALS | DATE | TopLine[®] | | | |
| DRAWN T. Au | 04/15/14 | | | | |
| ENG M. Hart | 04/15/14 | TITLE DAISY CHAIN TEST DIE TD136 21 x 21MM | | | |
| MFG | | SCALE 7:1 | SIZE A | DRAWING NO. | REV |
| QA | | | | 154136 | A |
| CUST | | DO NOT SCALE DRAWING | | | SHEET 1 OF 2 |
| REVISED | | | | | |

PERIMETER PAD TEST DIE DAISY CHAIN SHOWN WITHOUT CENTER PADS FOR CLARITY



SCALE 1.75:1

DIMENSION IN MICRONS
1.0mm = 1000µm

- Notes: (Unless Otherwise Specified)
1. DIE MATERIAL IS SILICON.
 2. DIE THICKNESS 250µm ~ 725µm.
 3. METALLIZATION 1.0µm ALUMINUM (Al).
 4. DIE IS WITHOUT PASSIVATION.
 5. WIRE BONDABLE WITH GOLD (Au) WIRE.
 6. DAISY CHAIN PAIRS.

| | | | | | |
|-------------|----------|---|------|-------------|--------------|
| APPROVALS | DATE | TopLine® | | | |
| DRAWN T.Au | 04/15/14 | TITLE DAISY CHAIN TEST DIE TD136 21 x 21MM | | | |
| ENG M. Hart | 04/15/14 | | | | |
| MFG | | SCALE | SIZE | DRAWING NO. | REV |
| QA | | 7:1 | A | 154136 | A |
| CUST | | DO NOT SCALE DRAWING | | | SHEET 2 OF 2 |
| REVISED | | | | | |